Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination YUI ET AL. | Examiner | Art Unit | Tae H. Yoon | 1796 | Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,776,883	07-1998	Vasudevan, Tirucherai Varahan	510/470
	В	US-			
	С	US-			
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Ξ	US-		,	
	1	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP 0 798 372 A1	10-1997	EPO		
	0					
	Ρ					
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

	NON-FATENT DOCUMENTS							
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
	C							
	v							
	w							
	x							

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classif ications may be US or foreign.